


<b>Search Notes</b> 	<b>Application/Control No.</b> 10596549	<b>Applicant(s)/Patent Under Reexamination</b> SISODIA ET AL.
	<b>Examiner</b> MICHAEL FIALKOWSKI	<b>Art Unit</b> 4173

SEARCHED			
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370	390 w/ text	12/2008	MF

SEARCH NOTES		
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Searched IEEE database with searches similar to those in EAST	12/2008	MF
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